





an Open Access Journal by MDPI

MEMS/NEMS Sensors: Advances, Trends and Challenges

Guest Editors:

Dr. Tao Tang

Department of Biomedical Engineering, National University of Singapore, Singapore 117583, Singapore

Dr. Ajay Kumar Yagati

Institute of Analytical Chemistry, Chemo- and Biosensors, University of Regensburg, Universitätsstraße 31, 93053 Regensburg, Germany

Deadline for manuscript submissions:

closed (15 October 2023)

Message from the Guest Editors

MEMS/NEMS are micro-/nano-electromechanical systems that integrate specific electrical and mechanical components on a nanoscale and microscale, allowing various micro-/nano targets to be measured quickly and precisely. Using MEMS sensors (e.g., microfluidic biosensors), for example, micrometer-sized cells (from hundreds of micrometers to sub-micrometers) can be characterized at frequencies exceeding 1000 Hz. On a nanomechanical nanoscale. structures provide indispensable functions such as sample introduction, separation, and purification when handling continuous single-molecule and single-nanoparticle processing. Nanoscale sensitivity enables the monitoring of various environments for viruses, bacteria, and particulate materials.

We invite researchers to contribute either original research or review articles focusing on, but not limited to:

- (i) MEMS/NEMS sensor design and applications;
- (ii) novel fabrication techniques/protocols;
- (iii) stabilization of the detection of MEMS/NEMS sensors;
- (iv) signal analysis methods for MEMS/NEMS sensors;
- (v) development of intelligent MEMS/NEMS sensors.











an Open Access Journal by MDPI

Editor-in-Chief

Prof. Dr. Flavio Canavero

Department of Electronics and Telecommunications, Politecnico di Torino, 10129 Torino, Italy

Message from the Editor-in-Chief

Electronics is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guest-edited by leading experts in selected topics of interest.

Author Benefits

Open Access: free for readers, with article processing charges (APC) paid by authors or their institutions.

High Visibility: indexed within Scopus, SCIE (Web of Science), CAPlus / SciFinder, Inspec, Ei Compendex and other databases.

Journal Rank: JCR - Q2 (Physics, Applied) / CiteScore - Q2 (Control and Systems

Engineering)

Contact Us